The electronic-structure origin of the anisotropic thermopower of nanolaminated Ti3SiC2 determined by polarized x-ray spectroscopy and Seebeck measurements - DTU Orbit (22/12/2018)

The electronic-structure origin of the anisotropic thermopower of nanolaminated Ti3SiC2 determined by polarized x-ray spectroscopy and Seebeck measurements. / Magnuson, Martin; Mattesini, Maurizio ; Van Nong, Ngo; Eklund, Per; Hultman, Lars.
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